



RADIO TEST REPORT

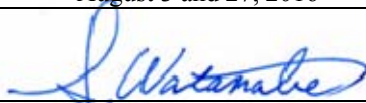
Test Report No. : 11393857H-R1

Applicant : TOKAI RIKA CO., LTD.
Type of Equipment : Smart Key Box
Model No. : B2H2J2H
Test regulation : FCC Part 15 Subpart C: 2016
FCC ID : MOZB2H2J2H
Test Result : Complied


1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 11393857H. 11393857H is replaced with this report.

Date of test: August 3 and 27, 2016

Representative test engineer:


Shinya Watanabe
Engineer
Consumer Technology Division

Approved by:
Date of test:


Motoya Imura
Engineer
Consumer Technology Division



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.

*As for the range of Accreditation in NVLAP, you may refer to the WEB address,
http://japan.ul.com/resources/emc_accredited/

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Ise EMC Lab.

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13-EM-F0429

REVISION HISTORY

Original Test Report No.: 11393857H

[illegible]

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SECTION 1: Customer information

Company Name : TOKAI RIKA CO., LTD
Address : 3-260 Toyota, Oguchi-cho, Niwa-gun, Aichi-ken, 480-0195 Japan
Telephone Number : +81-587-95-7042
Facsimile Number : +81-587-95-7449
Contact Person : Masaki Hayashi

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Smart Key Box
Model No. : B2H2J2H
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC 12.0 V
Receipt Date of Sample : August 3, 2016
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product description

Model No: B2H2J2H (referred to as the EUT in this report) is the Smart Key Box.

General Specification

Clock frequencies in the system : 8 MHz, 16 MHz

Radio Specification

Radio Type : Transceiver
Frequency of Operation : Channel1: 314.35 MHz
Modulation : FSK
Method of Frequency Generation : SAW
Antenna Type : Pattern Antenna, 3D Antenna
Operating Temperature Range : -20 to +60 deg. C
Operating Voltage Range : DC 8 to 16 V
Receiving frequency of Operation : 134.2 kHz *1)

*1) The test of receiver part was performed separately from this test report, and the conformability is confirmed.

[Bluetooth Version 4.0]

Frequency of Operation : 2402 - 2480MHz
Type of Modulation : GFSK

* The BLE module is a FCC certificated module made by MITSUMI ELECTRIC CO., LTD. Model number: WML-C75 (FCC ID: POO-WC75).

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC part 15 final revised on April 6, 2016.

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66 - 40.70MHz
and above 70MHz

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.207	N/A	N/A *1)	-
	IC: RSS-Gen 8.8	IC: RSS-Gen 8.8			
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(a)(1)	N/A	Complied	Radiated
	IC: -	IC: RSS-210 A1.1			
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(b)	12.5 dB 314.35 MHz Horizontal PK with Duty Factor	Complied	Radiated
	IC: RSS-Gen 6.12	IC: RSS-210 A1.2			
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.205 Section 15.209 Section 15.231(b)	8.1 dB 1886.100 MHz Horizontal PK with Duty Factor	Complied	Radiated
	IC: RSS-Gen 6.13	IC: RSS-210 A1.2, 4.4 RSS-Gen 8.9			
-20dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(c)	N/A	Complied	Radiated
	IC: -	IC: Reference data			

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

FCC Part 15.31 (e)

This EUT provides stable voltage (DC 3.3 V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.6	IC: RSS-210 A1.3	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Polarity	Radiated emission (Below 1GHz)			
	(3 m*)(+/-)		(10 m*)(+/-)	
	30 – 200 MHz	200 – 1000MHz	30 – 200 MHz	200 – 1000MHz
Horizontal	5.0 dB	5.3 dB	5.0 dB	5.0 dB
Vertical	4.7 dB	5.9 dB	5.0 dB	5.1 dB

Radiated emission (Above 1GHz)				
(3 m*)(+/-)		(1 m*)(+/-)		(10 m*)(+/-)
1 – 6GHz	6 – 18GHz	10 – 26.5 GHz	26.5 – 40GHz	1 -18 GHz
5.2 dB	5.4 dB	5.5 dB	5.5 dB	5.4 dB

* Measurement distance

Radiated emission test(3 m)

The data listed in this test report has enough margin, more than the site margin.

3.5 Test Location

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	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up.

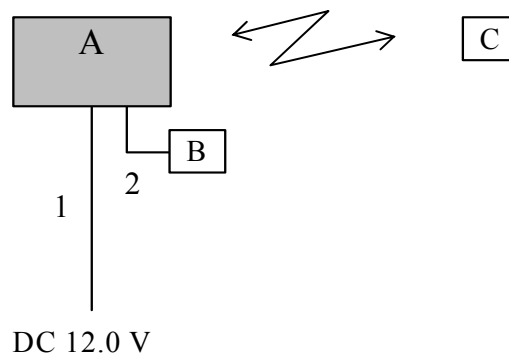
Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item*	Mode
Automatically Deactivate	Normal use mode
Electric Field Strength of Fundamental Emission	Transmitting mode *1)
Electric Field Strength of Spurious Emission	Transmitting mode under BLE communication
-20 dB & 99 % Occupied Bandwidth	Transmitting mode
* The system was configured in typical fashion (as a user would normally use it) for testing.	
*1) End users cannot change the settings of the output power of the product.	

4.2 Configuration and peripherals



*Item: iPhone was set on the corner in the anechoic chamber.
 * Test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Smart Key Box	B2H2J2H	001 *1) 002 *2)	TOKAI RIKI CO., LTD	EUT
B	Control Switch	-	-	-	-
C	iPhone	ME334J/A	F18M2MNQFFDR	Apple	-

*1) Used for Normal use mode only.

*2) Used for Transmitting mode only.

List of cables used

No.	Name	Length (m)	Shield		Remark
			Cable	Connector	
1	DC Cable	4.5	Unshielded	Unshielded	-
2	Signal Cable	0.1	Unshielded	Unshielded	-

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 1GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 3.

[Transmitting mode]

(Below 30 MHz)

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

(Above 30 MHz)

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3 m.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.1 kHz	9.1 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

- The carrier level was measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9 kHz - 3.2 GHz

Test data : APPENDIX

Test result : Pass

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	150 kHz	1.5 kHz	5.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Peak hold was applied as Worst-case measurement.							

Test data : APPENDIX
Test result : Pass

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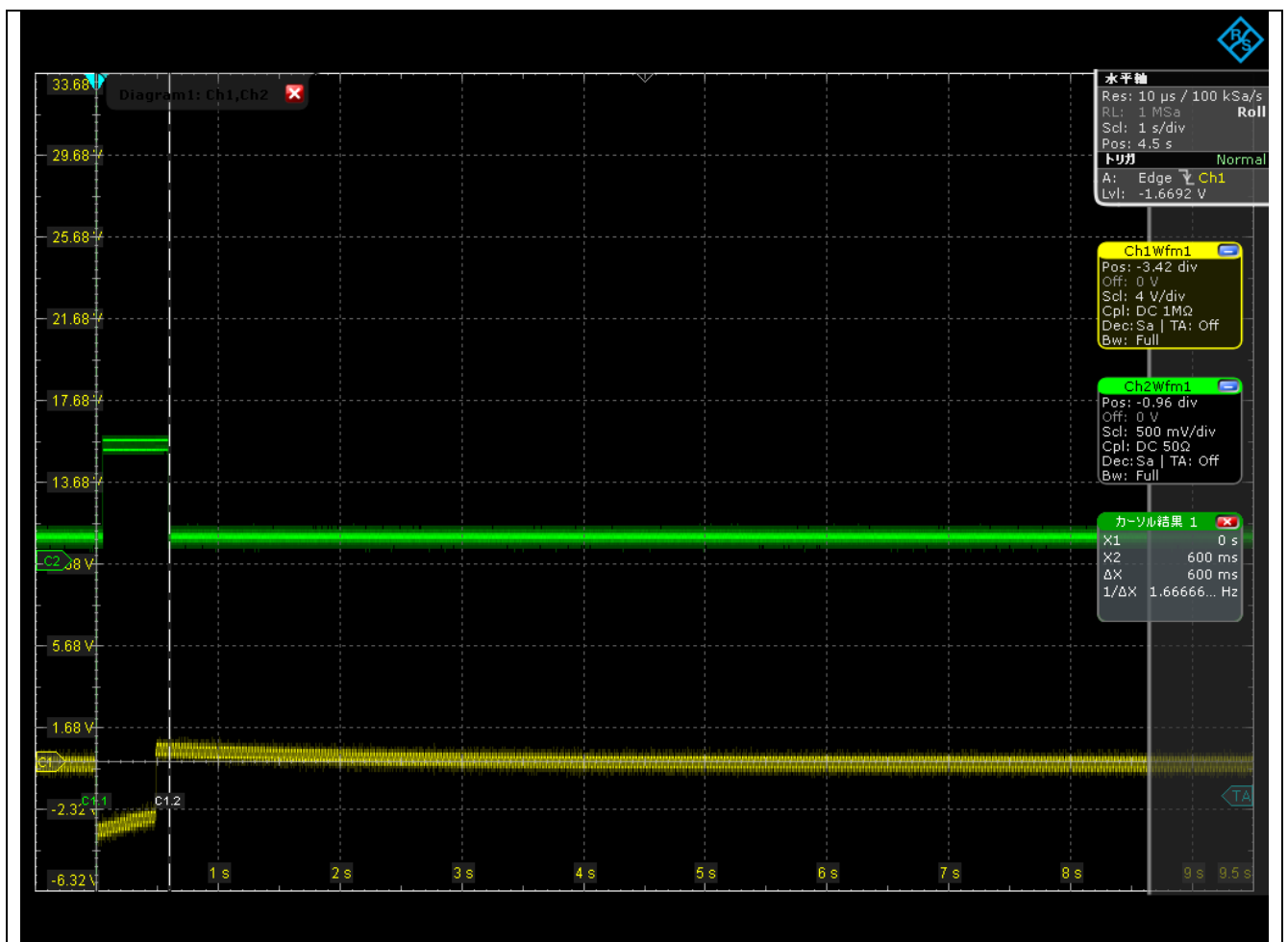
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APPENDIX 1: Test data

Automatically deactivate 314.35 MHz

Test place	Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No.	11393857H
Date	08/27/2016
Temperature/ Humidity	24 deg. C / 66 % RH
Engineer	Shinya Watanabe
Mode	Normal use mode 314.35 MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.60	5.00	Pass



Green line : Detected video of Tx signal
Yellow line : Activation trigger signal of Tx part

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

314.35 MHz

Test place	Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No.	11393857H
Date	08/03/2016
Temperature/ Humidity	23 deg. C / 73 % RH
Engineer	Shinya Watanabe
Mode	Transmitting mode 314.35 MHz

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	71.2	68.4	13.8	9.9	31.9	-	63.0	60.2	95.5	32.5	35.3	Carrier
628.700	PK	34.0	31.9	19.3	11.7	32.2	-	32.8	30.7	75.5	42.7	44.8	Outside
943.050	PK	42.5	41.2	22.1	13.2	30.9	-	46.9	45.6	75.5	28.6	29.9	Outside
1257.400	PK	47.7	46.4	24.9	5.4	34.2	-	43.8	42.5	75.5	31.7	33.0	Outside
1571.750	PK	45.9	45.3	25.7	5.6	33.3	-	43.9	43.3	73.9	30.0	30.6	Inside
1886.100	PK	47.1	44.9	27.0	5.8	32.5	-	47.4	45.2	75.5	28.1	30.3	Outside
2200.450	PK	NS	NS	-	-	-	-	-	-	73.9	-	-	Inside
2514.800	PK	NS	NS	-	-	-	-	-	-	75.5	-	-	Outside
2829.150	PK	NS	NS	-	-	-	-	-	-	73.9	-	-	Inside
3143.500	PK	NS	NS	-	-	-	-	-	-	75.5	-	-	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Distance factor) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	71.2	68.4	13.8	9.9	31.9	0.0	63.0	60.2	75.5	12.5	15.3	Carrier
628.700	PK	34.0	31.9	19.3	11.7	32.2	0.0	32.8	30.7	55.5	22.7	24.8	Outside
943.050	PK	42.5	41.2	22.1	13.2	30.9	0.0	46.9	45.6	55.5	8.6	9.9	Outside
1257.400	PK	47.7	46.4	24.9	5.4	34.2	0.0	43.8	42.5	55.5	11.7	13.0	Outside
1571.750	PK	45.9	45.3	25.7	5.6	33.3	0.0	43.9	43.3	53.9	10.0	10.6	Inside
1886.100	PK	47.1	44.9	27.0	5.8	32.5	0.0	47.4	45.2	55.5	8.1	10.3	Outside
2200.450	PK	NS	NS	-	-	-	0.0	-	-	53.9	-	-	Inside
2514.800	PK	NS	NS	-	-	-	0.0	-	-	55.5	-	-	Outside
2829.150	PK	NS	NS	-	-	-	0.0	-	-	53.9	-	-	Inside
3143.500	PK	NS	NS	-	-	-	0.0	-	-	55.5	-	-	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Distance factor) - Gain(Amplifier)

NS: No signal detected.

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:

Result of PK = Reading + Ant Factor + Loss (Cable + Attenuator +Distance factor) - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss (Cable + Attenuator +Distance factor) - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor: $20 \times \log(4.5 \text{ m}/3.0 \text{ m}) = 3.52 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

314.35 MHz under BLE communication

Test place : Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No. : 11393857H
Date : 08/03/2016
Temperature/ Humidity : 23 deg. C / 73 % RH
Engineer : Shinya Watanabe
Mode : Transmitting mode 314.35 MHz under BLE communication

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	70.7	68.0	13.8	9.9	31.9	-	62.5	59.8	95.5	33.0	35.7	Carrier
628.700	PK	33.9	31.8	19.3	11.7	32.2	-	32.7	30.6	75.5	42.8	44.9	Outside
943.050	PK	42.2	41.2	22.1	13.2	30.9	-	46.6	45.6	75.5	28.9	29.9	Outside
1257.400	PK	46.9	45.8	24.9	5.4	34.2	-	43.0	41.9	75.5	32.5	33.6	Outside
1571.750	PK	45.2	45.1	25.7	5.6	33.3	-	43.2	43.1	73.9	30.7	30.8	Inside
1886.100	PK	46.5	44.3	27.0	5.8	32.5	-	46.8	44.6	75.5	28.7	30.9	Outside
2200.450	PK	NS	NS	-	-	-	-	-	-	73.9	-	-	Inside
2514.800	PK	NS	NS	-	-	-	-	-	-	75.5	-	-	Outside
2829.150	PK	NS	NS	-	-	-	-	-	-	73.9	-	-	Inside
3143.500	PK	NS	NS	-	-	-	-	-	-	75.5	-	-	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Distance factor) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	70.7	68.0	13.8	9.9	31.9	0.0	62.5	59.8	75.5	13.0	15.7	Carrier
628.700	PK	33.9	31.8	19.3	11.7	32.2	0.0	32.7	30.6	55.5	22.8	24.9	Outside
943.050	PK	42.2	41.2	22.1	13.2	30.9	0.0	46.6	45.6	55.5	8.9	9.9	Outside
1257.400	PK	46.9	45.8	24.9	5.4	34.2	0.0	43.0	41.9	55.5	12.5	13.6	Outside
1571.750	PK	45.2	45.1	25.7	5.6	33.3	0.0	43.2	43.1	53.9	10.7	10.8	Inside
1886.100	PK	46.5	44.3	27.0	5.8	32.5	0.0	46.8	44.6	55.5	8.7	10.9	Outside
2200.450	PK	NS	NS	-	-	-	0.0	-	-	53.9	-	-	Inside
2514.800	PK	NS	NS	-	-	-	0.0	-	-	55.5	-	-	Outside
2829.150	PK	NS	NS	-	-	-	0.0	-	-	53.9	-	-	Inside
3143.500	PK	NS	NS	-	-	-	0.0	-	-	55.5	-	-	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Distance factor) - Gain(Amplifier)

NS: No signal detected.

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:

Result of PK = Reading + Ant Factor + Loss (Cable + Attenuator +Distance factor) - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss (Cable + Attenuator +Distance factor) - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor: $20 \times \log(4.5 \text{ m}/3.0 \text{ m}) = 3.52 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

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-20dB and 99% Occupied Bandwidth
314.35 MHz

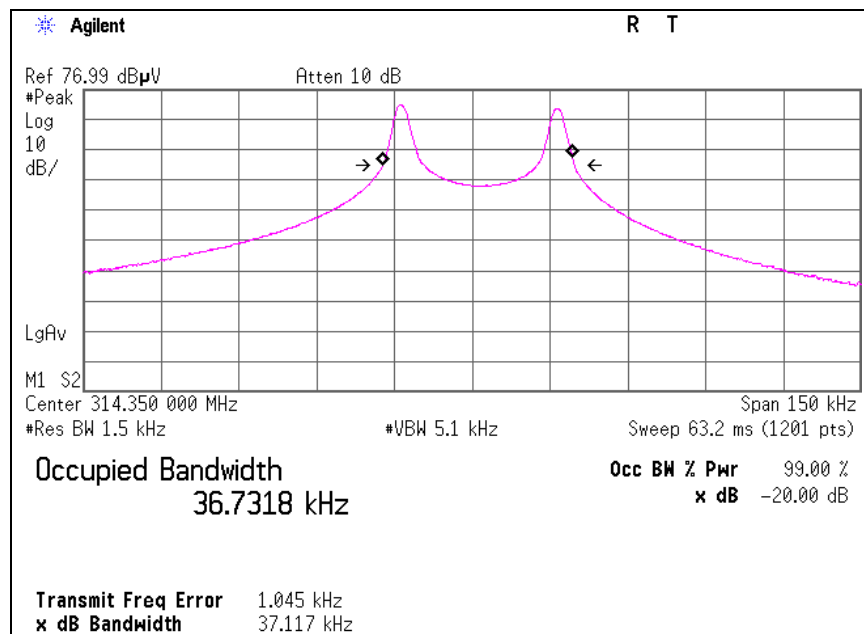
Test place : Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No. : 11393857H
Date : 08/27/2016
Temperature/ Humidity : 24 deg. C / 66 % RH
Engineer : Shinya Watanabe
Mode : Transmitting mode 314.35 MHz

Bandwidth Limit : Fundamental Frequency **314.35** MHz x 0.25% = 785.88 kHz

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
37.12	785.88	Pass

Bandwidth Limit : Fundamental Frequency **314.35** MHz x 0.25% = 785.88 kHz

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
36.73	785.88	Pass



APPENDIX 2: Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-04	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2015/10/02 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	1501	RE	2016/01/21 * 12
MJM-26	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MTR-10	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	RE	2016/01/29 * 12
MBA-05	Biconical Antenna	Schwarzbeck	BBA9106	1302	RE	2015/11/02 * 12
MLA-23	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-192	RE	2016/01/30 * 12
MCC-50	Coaxial Cable	UL Japan	-	-	RE	2016/06/20 * 12
MAT-68	Attenuator	Anritsu	MP721B	6200961025	RE	2015/11/12 * 12
MPA-14	Pre Amplifier	SONOMA INSTRUMENT	310	260833	RE	2016/03/18 * 12
MMM-10	DIGITAL HiTESTER	Hioki	3805	051201148	RE	2016/01/18 * 12
MSA-14	Spectrum Analyzer	Agilent	E4440A	MY48250080	RE	2015/10/07 * 12
MHA-21	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	RE	2015/08/10 * 12
MCC-141	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	RE	2016/06/21 * 12
MPA-12	MicroWave System Amplifier	Agilent	83017A	00650	RE	2015/10/01 * 12
OSC-01	Digital Oscilloscope	Rohde & Schwarz	RTO1004	200355	RE	2016/08/12 * 12
MLPA-07	Loop Antenna	UL Japan	-	-	RE	Pre Check

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth, and Automatically deactivate tests

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